**Power Electronics Research Group** 

# A Systematic Approach to Modeling Impedances and Current Distribution in Planar Magnetics

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# **Planar Magnetics in Power Electronics**



#### Magnetics with wire windings Primary Secondary winding winding N<sub>p</sub> turns N<sub>c</sub> turns Magnetic Flux, Φ Primary currenť Secondar + current Primary Secondary voltage ansfor Core

## **Advantages of Planar Magnetics:**

- 1. High repeatability
- 2. Suitable for high frequency
- 3. Good thermal performance
- 4. High power density

## Magnetics with planar windings

on PCB





on Chip





 L. Daniel, "Design of microfabricated inductors", IEEE Trans. Power Electron., 1999

 D.S. Gardner, "Review of on-chip inductor structures with magnetic films", *IEEE Trans. Magn., 2009*

# **Motivation**





1. Skin- and proximity- effects makes the modeling challenging.

2. Solving Maxwell's equations for all design options is not practical.

3. Existing analytical models usually have specific assumptions and are not easy to use.

4. Finite element modeling are:

- Time consuming
- Not analytical

# An analytical approach that is:

Accurate

Fast

# Easy to Use Widely Applicable

## 1. What is the most appropriate way to interleave many layers?



## 2. What is the most appropriate PCB spacing? Thin Middle Spacing Thick Middle Spacing



## 3. Other Design Options?

- 1) Leakage & Shielding Layers?
- 2) Hybrid Materials (Ni/Cu/FR4)?
- 3) Multi-Resonant Devices?
- 4) Etc...?

# **Two Commonly Shared Assumptions**



## Every model starts from assumptions ...



## (2) 1-D assumption

- Fields vary only along the thickness direction.
- Applicable when the flux is guided by the magnetic core.

#### Magnetic core guides the flux



Skin and proximity effects change current distribution

# **Modeling a Single Conductor Layer**



## Field diffusion equations:

$$H_X(z) = \frac{H_T \sinh(\Psi z) + H_B \sinh(\Psi (h - z))}{\sinh(\Psi h)}$$

Ampere's law:  $\Psi = \frac{1+j}{\delta} \quad \delta = \sqrt{\frac{2}{\mu\omega\sigma}}$  $\nabla \times H = I = \sigma E$ 

## E field as a function of H and K:

$$\begin{cases} E_T = E_Y(h) = \frac{\Psi}{\sigma} \left( \frac{H_T e^{\Psi h} - H_B}{e^{\Psi h} - e^{-\Psi h}} - \frac{H_B - H_T e^{-\Psi h}}{e^{\Psi h} - e^{-\Psi h}} \right) & \mathbf{Z}_a = \frac{\Psi(\mathbf{1} - \mathbf{e}^{-\Psi h})}{\sigma(\mathbf{1} + e^{-\Psi h})} \\ \\ E_B = E_Y(0) = \frac{\Psi}{\sigma} \left( \frac{H_T - H_B e^{-\Psi h}}{e^{\Psi h} - e^{-\Psi h}} - \frac{H_B e^{\Psi h} - H_T}{e^{\Psi h} - e^{-\Psi h}} \right) & \mathbf{Z}_b = \frac{2\Psi e^{-\Psi h}}{\sigma(\mathbf{1} - e^{-2\Psi h})} \end{cases}$$

KVL/KCL relationships:  

$$V/m \quad \Omega \quad A/m$$

$$\begin{cases}
E_T = Z_a H_T + Z_b K \\
E_B = Z_b K - Z_a H_B \\
K = H_T - H_B
\end{cases}$$



**E**:

**KVL** 

**KCL** 

#### Electromagnetic Fields



through variables ~ unit (**A/m**) across variable ~ unit (V/m) impedances ~ unit ( $\Omega$ )  $Z_a, Z_b$ :

# **Modeling Two Adjacent Layers**



## Intuition:

- Two three-terminal networks
- Connected by the H field between them

## Faraday's Law and Field Continuity

$$E_{B1}d - V_1 = -\frac{d\Phi_{B1}}{dt} \quad E_{T2}d - V_2 = -\frac{d\Phi_{T2}}{dt}$$
$$\frac{d\Phi_{T2}}{dt} = \frac{d\Phi_{B1}}{dt} + \frac{d\Phi_A}{dt}$$

# Flux Linking Two Layers:





# **Modeling Layers with Multiple Turns**



Fields distributions in multiple-turns layers are linearly related to those in single-turn layers

Multiple turns → Additional Linear Conversions



# Modeling n Layers, the Core and the Air Gap

#### Additional Impedances Representing the Cores and Air Gaps

**TOP Side** 



## Modeling vias is equivalent to adding KVL, KCL constraints:

Layer i and Layer j in series Layer k and Layer l in parallel

$$\begin{cases} V_i + V_j = V_a \\ V_k = V_l = V_b \end{cases} \begin{cases} I_i = I_j = I_a \\ I_k + I_l = I_b \end{cases}$$

#### Connect the layer ports in the same pattern as they are in the real circuit



# **Summary of the Model**





# **Use the Model Numerically**



## Netlist generation and full circuit simulation



Use Python/Matlab scripts to rapidly generate the netlist ~~ Use SPICE to rapidly solve the netlist ~~ A GUI is under development ~~

![](_page_12_Picture_1.jpeg)

![](_page_12_Figure_2.jpeg)

#### **Parameter Extractions Using:**

Open and Short Circuit Simulations.

• Impedance Matrix

 $V_{N\times 1} = Z_{N\times N} \times I_{N\times 1}$ 

• Extract Parameters for Other Circuit Models.

#### **Conventional Transformer T Model:**

![](_page_12_Figure_9.jpeg)

# **Verifications and Application Examples**

# l'lir

## **Experimental Measurements**

![](_page_13_Figure_3.jpeg)

![](_page_13_Picture_4.jpeg)

ELP22 Cores: window width/height ratio ~ 3:1

![](_page_13_Figure_6.jpeg)

## **ANSYS Maxwell FEM Simulations**

# **Impacts of Interleaving Patterns**

![](_page_14_Picture_1.jpeg)

## Comparing the $P_{ac}$ and $E_{ac}$ of three 1:1 transformers with three different interleaving patterns

![](_page_14_Figure_3.jpeg)

Interleaving has to be done in the right way !!!

# **Impacts of PCB Layer Stacks**

![](_page_15_Picture_1.jpeg)

![](_page_15_Figure_2.jpeg)

# **Practical Considerations**

![](_page_16_Picture_1.jpeg)

![](_page_16_Figure_2.jpeg)

![](_page_16_Picture_3.jpeg)

(c/h<sub>w</sub><40%, err<10%)

(c) Conductor to core clearances (side spacing)

![](_page_16_Picture_6.jpeg)

(c/w<sub>w</sub><40%, err<10%)

(d) Conductor to Conductor clearances (middle spacing)

![](_page_16_Figure_9.jpeg)

(c/h<sub>w</sub>>40%, err<10%)

(e) Fringing effects

# **Summary**

![](_page_17_Picture_1.jpeg)

![](_page_17_Figure_2.jpeg)

![](_page_18_Picture_0.jpeg)

![](_page_18_Picture_1.jpeg)

## **Acknowledgement:**

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![](_page_18_Picture_4.jpeg)

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## **Reference:**

• M. Chen, M. Araghchini, K.K. Afridi, J.H. Lang, C.R. Sullivan, and D.J. Perreault, "A Systematic Approach to Modeling Impedances and Current Distribution in Planar Magnetics," *Proc. of the IEEE Workshop on Control and Modeling for Power Electronics (COMPEL)*, June 2014.